

# Search Notes



Application/Control No.

10/675,244

Examiner

Hiep Nguyen

Applicant(s)/Patent under  
Reexamination

MULLER ET AL.

Art Unit

2816

## SEARCHED

Class	Subclass	Date	Examiner
All searches updated		02.23.05	Hn

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST See attachment	02.23.05	Hn